國立交通大學

電機學院IC設計產業研發碩士班

碩士論文

覆晶封裝在封裝與機板共同設計階段一個線長驅策 及被範圍條件限制的訊號區塊擺放方法

Wire Length Driven Flip-Chip Pin-Out Designation by Range Constrained Pin-Block Floorplanning in Package-Board Codesign

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國立交通大學電機學院產業研發碩士班

搞 要

隨著先進製程技術快速發展之下, 越來越多的電路可以被整合在單一晶片裡, 這 樣的趨勢造成封裝設計與訊號之間的連接變得更爲複雜。然而, 傳統打線封裝技術在 一些特殊設計上已不敷實用, 取而代之的是目前已被廣泛使用的覆晶封裝技術。覆晶 封裝設計裡在封裝與機板共同設計階段中, 一般排放錫球的方式都是以資深工程師依 經驗手動擺放, 這是一個很費時又反覆的過程, 影響了產品上市的時間 (TTM)。因 此, [1]以自動化程式產生面陣列引腳錫球圖 (Ball Grid Array, BGA), 以利工程師 做事後微調的動作,大幅地減少這排放過程花費的時間。在這篇論文裡,我們展現了自 動化產生面陣列引腳錫球圖的過程,並且在封裝與機板共同設計階段提出一個被範圍 條件限制的訊號區塊擺放改進方法並且使用模擬退火演算法 (Simulated Annealing Algorithm, SA) 來執行。同時我們也對此特殊擺放的需求發展一個表示方法。我們 提出的改進方法在訊號組態資訊參數設定上較有彈性, 以及可以確保最小的封裝尺寸, 實驗數據結果顯示我們提出的改進方法優於論文 [1]的擺放方法。

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Wire Length Driven Flip-Chip Pin-Out Designation by Range Constrained Pin-Block Floorplanning in Package-Board Codesign

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ABSTRACT

With the advanced fabrication technique developing rapidly, more and more circuits could be integrated in a single chip. This trend will cause the complication in package designs and signal interconnection. However, the typical peripheral wire-bond design may not be proper for use in some particular designs, flip-chip becomes a better choice. In flipchip design, engineers generally arrange the ball chart in the manual manner on experience in package-board codesign. This process is iterative, time-consuming and it will lengthen the time-to-market (TTM) of products. [1] proposed a method of generating the BGA ball chart automatically by pin-block design and floorplanning, thus helped engineers respin the ball chart slightly and saved the arranging time dramatically. In this thesis, we exhibit the procedure of accomplishing the method of [1] and improve the flooplanner in [1]. The proposed pin-block floorplanner designates pin-out for flip-chip BGA package by using the range constraints, and it is based on simulated annealing algorithm. We also develop a representation for this special floorplanning requirement. It not only has flexibility on specifying critical parameters of the pin configuration, but also guarantees the minimum package size. Experimental results show that improved pin-block floorplanner can perform a better pin assignment than that in [1].

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Chapter 1

Introduction

Moore's Law has been announced in 1965, it has gone by almost a half of century. Moore's Law says that the amounts of transistors on the single chip would be double per two years. In fact, the fabrication technique has improved over double in current age of deep submicron (DSM), that is, the amounts of transistors on the single chip would be double per eighteen months. As silicon technology scales, more and more circuits could be integrated in a single chip. The amounts of input/output (I/O) signals increase dramatically every unit area. Then, the I/O densities become higher and the space of finite routing resource becomes smaller. This trend will cause the complication in package designs and interaction between package and board. There were several works [17], [18], [20] which were related to package and board physical designs. [17] presented a simulated annealing technique to find a pin assignment solution which considered the routability issue on PGA package and board, but no other DSM effects were considered. [18] presented some efficient patterns to assign the solar balls on board in order to meet the high I/O count for certain products, but still existed a limit to the number of solar balls that were used for power delivery, and routability between package and board. [20] proposed an efficient algorithm which assigned and routed the solder balls of BGA package. But, its fanout routing was only in a single layer and only the routability issue on board was considered.

Comparing with the typical peripheral wire-bond design, flip-chip design can accom-

modate more input/output (I/O) signals, and can obtain the smaller area of package size. The ball grid array (BGA) solder balls are arranged between package and board. BGA form fully utilizes the area beneath the substrate to assign signal pins and makes up for the routability that the typical peripheral wire-bond design is restricted. Besides, the power and ground pins are located at the center of package and the die is located upon these power and ground pins. The heat generated from the die can be diffused efficiently through these pins in order to avoid the Hot Spot, and thus reduce the defected rate of chips. Flip-chip design has been used widely at present. For package-board codesign, engineers generally arrange the ball chart in the manual manner on experience. This process is iterative, time-consuming and it will lengthen the time-to-market (TTM) of products. [1] proposed a method of generating the BGA ball chart automatically by floorplanning pin-block, thus helped engineers respin the ball chart slightly and saved the arranging time dramatically.

Figure 1.1 shows the typical interface design flow for IC-package-board codesign and a new design flow based on proposed automation design process, respectively. In Figure $1.1(a)$, we can observe that it spends about one week designating pin-out manually and estimating package size. Then, it spends another one week locating I/O buffer and pad manually and estimating die size. In order to tradeoff signal performance and package cost, engineers always take few weeks to rework package substrate and PCB layout, and rearrange pin-out until the all requirements are satisfied.

On the contrary, Figure 1.1(b) shows the proposed process in [1]. Comparing with manual works shown in Figure 1.1 (a), it completes the works more efficient. The run time of designating pin-out automatically and acquiring the minimum package size is less than five seconds and it just needs about half or one day to fine-tune pin-out. Similarly, if the idea of locating I/O buffer and pad automatically is available, the expected run time of optimizing die size is less than ten seconds. Furthermore, the run time of finetuning pad location is expectably half or one day. Obviously, it can shorten the runtime throughout the automation process and obtain the minimum package size and die size.

Figure 1.1: The typical flow and proposed approach in interface design for IC-packageboard codesign. The focus of [1] is to automate pin-out designation and to minimize package size during design stage [1].

The focus of [1] is to automate pin-out designation and to minimize package size during package-board codesign stage.

Research [1] is the first attempt in solving flip-chip pin-out placement problem in package-board codesign. It evaluates the minimum package size which can accommodate all pins. Then, it will construct pin blocks, which consist of signal-pin blocks and powerpin blocks, and fill them into the minimum package to create the rough pin-out. Finally, the pin-block floorplan will be made into a square one by using an iterative algorithm. The square floorplan can accommodate all pin blocks and has no excess pin blocks in each side. We will accomplish the aforementioned issue in [1] and describe the detail of the automation process implementation in Chapter 3.

However, the method in [1] is less flexible in determining pin configuration chart. The reason is that, we should specify the order for all pin blocks in each side. Because of this order restriction, pin blocks with no freedom have no chance to be placed in better positions in each side of the chip and the results of this floorplan will incur a big cost on the wire length. While empty spaces appear on this floorplan, the worse positions (e.g. the pin blocks which are specified in side1 are assigned in side4 and have empty spaces between the pin blocks which belong to the same group, as shown in Figure 1.2 (b)) will cause another cost as well. Consequently, we have surveyed some methods about floorplanning and placement and try to improve the floorplanner in [1]. The target is to improve the design process and obtain the optimal pin-out.

We have studied some researches about floorplanning and placement which are as follows. Floorplans can be divided into two categories, the slicing floorplanning and nonslicing floorplanning. Many floorplanners are based on slicing floorplans [5], [6], [7], [8]. There are two major advantages of using slicing floorplans. Firstly, the one to one correspondence between skewed slicing trees and normalized Polish expression reduces the search space and leads to a faster runtime. By using simulated annealing method, the efficiency of this benefit is more significant. Secondly, the shape flexibility, that are the modules which may assume any shape permitted by its shape constraints (e.g. a range

Figure 1.2: While empty spaces appear on floorplan, the worse positions will cause another cost as well.

of possible aspect ratios), can be fully exploited to give a close to optimal final packing based on an efficient shape curve computational technique.

Because of some constraints by using slicing floorplans, there are also some interesting researches in non-slicing floorplans recently. Here are three methods, sequence-pair [3], B*-trees [9], O-Tree [10], which have been proposed for placement of hard modules. However, the B*-trees [9] method can also handle soft modules. The sequence-pair method has later been extended to handle pre-placed modules [2] and soft modules [4]. Recently, there is a research that can handle all of the placement constraint simultaneously in floorplan design [13], including pre-placed constraint, range constraint, boundary constraint, alignment, abutment, and clustering, etc. In order to handle soft modules, it has to solve a mathematical programming problem to determine the exact shape of each module numerous times in the floorplanning process. It wastes a lots of system's resources and results in long runtime. By the way, the B*-trees method has been also extended to handle pre-placed modules [11] and boundary constraint [12]. Comparing with B*-trees [9] method, [11] provides more complete and stronger structure to solve pre-placed modules

problems. In floorplanning, it is important to allow users to specify placement constraints in order to get improvement of system's performance, chip area or wire length, etc.

Three common types of placement constraints are pre-placed constraint, boundary constraint, and range constraint. For pre-placed constraint, we require a module to place exactly at a certain position in the final packing. In fact, the problem of floorplanning with obstacles can be solved by treating the obstacles as pre-placed modules. This problem has been considered in both slicing and non-slicing floorplans [2], [4], [6], [11], [13]. For boundary constraint, we require a module to be placed along one particular side of the final floorplan: on the left, on the right, at the bottom, or at the top. This is useful when users want to place some specific modules along the boundary for getting good inputoutput connections. This problem is considered recently in both slicing and non-slicing floorplans [7], [12], [13]. For range constraint, we require a module to be placed within a given rectangular region in the final packing. This is indeed a more general formulation of the placement constraint problem and any pre-placed constraint can be written as a range constraint by specifying the rectangular region such that it has the same size as the module itself.

1.1 Our Contributions

In our proposed methodology, we can consider the core region as a pre-placed module which must be placed in the center of the final packing and pin-blocks as range constraint modules which must be placed within given rectangular regions such that there are no two rectangular blocks overlapping.

In this thesis, we exhibit the procedure of accomplishing this BGA package [1] automatically. We also develop a new representation for this special floorplanning requirement and improve the floorplanner in [1] by using range constraint and simulated annealing algorithm to place pin-blocks. The experimental results show that our improved pin-block floorplanner has more flexibility on specifying critical parameters of the pin configuration and can obtain a better pin-out which has lower cost than that in [1]. Finally, we will show the experimental results of the method in [1] and our improved pin-block floorplanner, and the improvement of our improved pin-block floorplanner.

1.2 Organization of this Thesis

The organization of this thesis is as follows. Chapter 2 describes a key previous work and the detail of the automation process implementation in [1]. Chapter 3 describes our improved pin-block floorplanner which is implemented by simulated annealing algorithm with range constraint. Chapter 4 shows the experimental results. We draw conclusions in Chapter 5.

Chapter 2

Pin-Out Designation and Package Size Optimization by Pin-Block Floorplanning

In this chapter, we introduce a novel and efficient approach [1] to designate pin-out automatically for flip-chip BGA package when designing chipsets. This approach has taken practical experiences and techniques into account, such as signal integrity, power delivery and routability. It can not only reduce the runtime by means of automation process, but also guarantee the minimum package size and the minimum core size during design stage.

2.1 Overview of Fast Flip-Chip Pin-Out Designation Respin by Pin-Block Design and Floorplanning

2.1.1 Package-Board Codesign by Considering Signal Integrity and Power Delivery

Figure 2.1 depicts a sketch of PCB layout. Generally the length of signal net from package pin to component or connector on PCB is the primary contributor to parasitic inductance which will make package pins exacerbate simultaneous switching noise (SSN). In order to minimize the physical length of the package pins thus reduce the total parasitic induc-

Figure 2.1: A general layout of PCB board. The location of pins on IC package should be restricted in specific regions to meet minimum net-length [1].

Figure 2.2: The visible package substrate of chipsets.

tance, the signal pins should be allocated and restricted in the particular region according to the certain location of corresponding components or connectors.

Figure 2.2 represents a diagram of a complete flip-chip package. The top layer denotes the die which consists of some logic circuits, I/O pins and I/O buffers. The middle layer denotes the package substrate. Then, the bottom layer denotes the printed circuit board. There are some important connecting devices including PCB components or connectors, etc. on the board. By the way, this diagram shows the visible package substrate of the real industrial case.

Figure 2.3 shows the simplified cross-section of a flip-chip package which is mounted on PCB board. The solder bumps are considered as a bridge that is used to connect the die and the substrate, and the solder balls are exploited to connect the substrate and the PCB board. Based on experienced method, the bumps which are beneath the die and located close to die edge will be routed signal nets through package top layer. On the contrary, the bumps which are located around the core of die will be routed signals through vias and fanned out nets on package bottom layer. For package pins, the solder balls are routed signal nets in the same rule to share finite routing resource.

Figure 2.3: The cross-section of a flip-chip package which is mounted on PCB board [1].

For routability, the routing issues should be considered including the net width, spacing, the distance between the pad pitches and so on. Thus, these factors will influent the excess row number used for placing signal pins. By demonstrating in [1], the space between two pads can only be penetrated by two nets. That means only 3 signal nets can be fanned out on PCB top layer. Another 3 signal nets on the same column can be routed through vias and fanned out on PCB bottom layer. In addition, the outer pins include power and ground pins which are routed through vias to the second and third layer of PCB board, besides the signal pins. So, the average row number of outer pins is 8.

As for signal integrity, return path inductance should be considered as well. The unfavorable placement and number of return path pin, power or ground, will maximize current return loops and increase return path inductance. This will dramatically degrade signal integrity and exacerbate radiated emissions. The optimal pin designation is to place signal pin and power or ground pin proximally close to each other, so that each signal pin can be tightly coupled to a return path pin. This will minimize the effect of the return path inductance. However, this optimal design will create such signal-pin blocks which have fewer signal pins within a large block area. [1] addresses six proposed signal-pin patterns for user to make decision that which pattern is most properly exploited for placing signal pins. There exists tradeoff between signal performance and package cost.

Considering power delivery issue, designers can freely define the demand of power

Figure 2.4: A complete pin block includes signal-pin block and its related power-pin block. It is located on the region close to corresponding component on PCB [1].

pins for individual signal configuration. While the signal-pin block is constructed, the proposed automation process will create the power-pin block then place it adjacent to the related signal-pin block. The signal-pin block and the power-pin block will be formed into a complete pin block, as shown in Figure 2.4.

2.1.2 Pin-Out Designation Automation by Pin-Block Construction and Floorplanning

In the stage of pin-block construction, designers should determine pin configuration chart, shown in Figure 2.5. The pin configuration chart include all critical parameters defined for placing signal pins, including signal-pin name, selected signal-pin pattern (pattern), the own specific bus (group), the distribution region (side), placement sequence (order), power-pin name and the number of power pins.

After finishing the implementation and placement of all blocks, a rough pin designa-

Signal-pin name	I/O buffer type	I/O width (num)	I/O height (nm)	Selected signal-pin pattern	Group	Side	Order	Power-pin name	Power-pin NO.
AD $P[0:7]$	AIO1XH0J	40	500					VDDA	10
AD $N[0:7]$	AIO1XH0J	40	500					VDDA	10
\cdots	\cdots	\cdots	\cdots	\cdots	\cdots		\cdots	\cdots	
AD[0:15]	BIO1XH0J	30	350	3	2		$\overline{2}$	VDDB	8
\cdots	\cdots	\cdots	\cdots	\cdots	\cdots	\cdots	\cdots	\cdots	\cdots
$TEST_N[0:6]$	CIO1XH0J	25	400	4	3	2		VDDC	5
TEST OUT[0:6]	CIO1XH0J	25	400	4	3	$\overline{2}$		VDDC	5
TRAP[0:6]	CIO1XH1J	25	400	4	3	2		VDDC	5
\cdots	\cdots	\cdots	\cdots	\cdots	\cdots		\cdots	\cdots	\cdots

Figure 2.5: An example of pin configuration chart. In this pin configuration we can define specific information as inputs of our proposed automated approach [1].

Figure 2.6: A minimum package size can be obtained after we designate and floorplan all pin blocks [1].

tion will be obtained, shown in Figure 2.6. A*ij* denote the specific bus, where i and j are to represent side and order that blocks are located on and defined in pin configuration by designer. Furthermore designer can acquire parameters w_{ij} and h_{ij} (w and h represent the width and height of each block respectively). At the same time, parameters E_1 to E_4 can be evaluated from this rough pin designation (E_1 to E_4 represent the width or height of the empty or excess area in each side of minimum package model). The next step is to minimize package size by mathematical programming and acquire a feasible pin designation. The problem is formulated as follows:

Minimize
$$
f = \sum_{j=1,3} (\sum_i w_{ji} + E_j) h_j + \sum_{j=2,4} (\sum_i h_{ji} + E_j) w_j + F
$$

subject to

$$
W = w_4 + \sum_{i} w_{1i} + E_1 = w_2 + \sum_{i} w_{3i} + E_3
$$
 (2.1)

$$
H = h_1 + \sum_i h_{2i} + E_2 = h_3 + \sum_i h_{4i} + E_4 \tag{2.2}
$$

$$
W = H \tag{2.3}
$$

$$
E_1 + E_2 + E_3 + E_4 \ge 0 \tag{2.4}
$$

where w_{1i} , h_1 , w_2 , w_{3i} , h_3 , h_{4i} , w_4 can be evaluated in the previous step, E_1 to E_4 represent the width or height of the empty or excess area in each side of minimum package model, and F represent the area of core region, shown in Figure 2.6. Equation (2.1) to (2.3) will restrict the shape of package to be square. The purpose of Equation (2.4) is to insure that the minimum package size can accommodate all pin blocks with almost no void pin positions.

The final step of proposed methodology is to floorplan pin blocks, that is, to finetune the location of pins in the excess area and fill them into the adjacent empty area. Figure 2.6 shows an example to represent how the rough floorplan can be translated to a square one.

Figure 2.7: The design flow of automation process.

2.2 Designation Automation Flow

At the beginning of this procedure, we show the design flow of automation process below (as in Figure 3.1).There are two critical parts in this design flow, Part I and Part II, respectively. There are three steps in Part I, *evaluate pin block*, *construct pin block* and *evaluate minimum package size*, respectively. We should consider several constraints among Part I. Constraints 1-1: considered the location of the components on PCB. The longer wire length of signal net has been pulled, the larger parasitic instance is created. The parasitic instance will cause package pins to exacerbate simultaneous switching noise (SSN). Thus, the signal pins should be placed according to the position of relative components and connectors on print circuit board. Constraints 1-2: package size vs. ball number. Because of the routability on PCB top layer, the space between two pads can only be penetrated by two nets. That means the locations of PCB pad near PCB edge can only allow three signal pins on one column. Other symmetrical four signal pins closed to the core of die can place solder balls through vias. As a result, the average of row number of outer-pin (power-pin, ground-pin and signal-pin) will be predefined as eight. Constraints 1-3: pin patterns about the top and bottom layer routing. Making a decision

between these six patterns is based on experience of engineers. According to the characteristics of signal-pin patterns, engineers can select an adaptable pattern for designating pins.

There are two steps in Part II, *fill pin block in minimum package model to create rough pin-out* and *shift pin block to obtain final pin-out*. User defines the signal pins in which side and in which group. Then, our program constructs the signal-pin blocks with chosen patterns and also builds the specific power-pin blocks for related interface. After previous procedure, it will group the signal-pin blocks and the power-pin blocks into modules such as pin blocks and fill pin blocks in the minimum package model to create the rough pin-out floorplan. In next step, we propose an algorithm to regulate the exceeding region of the rough pin-out flooplan into a square one which is accommodated all pin blocks.

2.3 Pin-Block Floorplanning

At present, we just get a rough floorplan which owns the property described previously with the minimum core size and the minimum package size. However, this rough floorplan still has pin block in excess area and is not consistent with the size of minimum package floorplan. So, we proposed an simple algorithm to make the rough floorplan into a square one. This algorithm does not destroy the position of pin block enormously and make the location of pin block as near to the corresponding side of the chip as possible. The algorithm is shown as follows:

Algorithm:

1. i ← 1 //start from side 1 2. $i - 1 \leftarrow 4$, iff $i = 1$; $i + 1 \leftarrow 1$, iff $i = 4$ 3. while $(E_i < 0)$ do, for $i \in \{1, 2, 3, 4\}$ 4. if $(E_i \neq 0 \& \& E_i < 0)$

5. if $E_{i-1} > E_{i+1}$

6. shift pins clockwise //fill the pin block into empty area in last side until

the current E_i value is zero

7.
$$
E_i \leftarrow 0, E_{i-1} \leftarrow E_{i-1} + E_i
$$

8. else

9. shift pins anticlockwise //split the pin block in excess area then group it

into next side

10.
$$
E_i \leftarrow 0, E_{i+1} \leftarrow E_{i+1} + E_i
$$

11.
$$
i \leftarrow i + 1 \text{ //check next side}
$$

12. until all E_i values are large than or equal to zero

The algorithm starts form the side1 of the rough floorplan. It will check whether this side have excess pin block. If this side has excess blocks, the algorithm will check the empty space of the previous side and the next side. If the space of the previous side is greater than the other, the algorithm will shift pins in the clockwise direction and fill the pin blocks which are in the excess area into the empty area in the previous side until the current value of E_i is zero. Otherwise, it will shift pins in the anticlockwise direction and split the pin blocks in excess area into one module, then it will group it into the next side. Every iteration of this procedure will check the value of E_i in each side whether it is greater than zero. While all values of E*ⁱ* in every side are greater than zero, then the algorithm will stop and represent the final square floorplan. Next, We will implement two real cases in practice, that will be more clearly about describing this automation process.

The program will gather statistics about the columns of pins in each side by means of feeding the program with the pin-lists. Afterwards, the program solves the linear problem to computer the minimum core size and the minimum package size. Figure 2.8 describes the columns of pins in each side, the minimum core size, the minimum package size, the columns in excess region of the package and the sum of all values of E_i .

The rough floorplans of this two cases are showed as in Figure 2.9 and Figure 2.10 respectively. In Figure 2.9, we can observe that the side1 has columns in the excess area $(E_1 = -3)$, the side2 has empty space $(E_2 = 2)$, the side3 has excess space $(E_3 = -6)$

Figure 2.8: (a) Result in Case I. (b) Result in Case II.

and the side4 has columns in empty area $(E_4 = 7)$ in case I. In Figure 2.10, we find that the side1 has excess space $(E_1 = -5)$, the side2 has columns in excess area $(E_2 = -1)$, the side3 has columns in excess area $(E_3 = -3)$ and the side4 has empty space $(E_4 = 12)$ in case II. Next, our program will implement the simple algorithm described above. The rough floorplan will be shifted pins and will be made as a square one.

Figure 2.11 and Figure 2.12 describe the proceedings of carrying out the algorithm which makes the rough floorplan as a square one. In Figure 2.11 (a), the side1 has three columns of pin blocks in excess area $(E_1 = -3)$ and, thus, the algorithm will check the empty space of the previous side (E_4) and the next side (E_2) . The space of the previous side is greater than the other (i.e. $E_4 = 7 > E_2 = 2$), the algorithm will shift pins in the clockwise direction and fill the pin blocks which are in the excess area into the empty area in the previous side until the current value of E_i (E_1) is zero. The E_1 will be set to 0, E_4 is equal to 4 (i.e. $7-3$) and E_2 E_3 are the same, as shown in Figure 2.11 (b). Next step, we check the side2 (in Figure 2.11 (b)). Because the values of E_2 is greater than zero $(E_2 = 2)$, so it is kept in the original status. Then, the side3 (in Figure 2.11 (b)) has six columns of pin blocks in excess area $(E_3 = -6)$. The space of the next side is

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Figure 2.9: Rough floorplan in Case I. (uppercase P denotes the minimum package size, uppercase C denotes the minimum core size, uppercase N denotes nothing and pin-block groups are denoted in shaded blocks.)

Figure 2.10: Rough floorplan in Case II. (uppercase P denotes the minimum package size, uppercase C denotes the minimum core size, uppercase N denotes nothing and pin-block groups are denoted in shaded blocks.)

Figure 2.11: Diagrams for interpretation of carrying out the algorithm from the rough floorplan to the final floorplan in Case I.

Figure 2.12: Diagrams for interpretation of carrying out the algorithm from the rough floorplan to the final floorplan in Case II.

greater than the other $(E_4 = 4 > E_2 = 2)$ and, thus, the algorithm will fill the pin blocks which are in excess area into empty area in next side (E_4) . The E_3 will be set to 0, E_4 is equal to -2 (i.e. $4-6$) and E_1 E_2 are the same, as shown in Figure 2.11 (c). Next step, we check the side4 (in Figure 2.11 (c)) and side4 has two columns of pin blocks in excess area ($E_4 = -2$). The space of the previous side is equal to the other ($E_3 = E_1 = 0$) and, thus, the algorithm will fill the pin blocks which are in excess area into the next side (E_1) . Then (E_4) will be set to 0, (E_1) is equal to -2 (i.e. $0-2$), as showed in Figure 2.11 (d). At present, it is just implemented in one cycle. In fact, the algorithm is iterative and will implement repeatedly until the value of E_i in each side is greater than zero. Otherwise, it will never stop. Figure 2.13 shows the final floorplan of case I and is accurate at the corresponding Figure 2.11 (e). Case II is a more general case about this algorithm, as shown similarly in Figure 2.12 and Figure 2.14.

		LTCAD_NIOLTCAD_PIONSS		VSS	$\mathfrak{a}_{\mathfrak{A}}$	YSS		LTCAD_NO LTCAD PO VSS		VSS		LRCAD_NIOLRCAD_PIOVSS			122	ISS		LRCAD_NO LRCAD QO IVDC		IW	$[\hspace{-0.3ex}[\mathfrak{y}]\hspace{-0.3ex}]$	$[\![\mathbf{W}]\!]$	$M^{(n)}$	$ \mathcal{V}\rangle\!\!\!\!\rangle$	$ \mathcal{V}\mathcal{Y}\mathcal{Y} $	$\mathbb{N} \mathbb{D}$		
		122	122		LTCAD N O TCAD P5 YSS		122	122	DAWN (1965)		122	122	W	10° 155 180.00 ps vss				W	ISS	VDD	VSS	VSS	122	TSS	VSS	DLLEN#		
		LTCAD_P12VSS	$\sqrt{32}$	VSS	35		LTCAD_N2 LTCAD_P2 VSS		VSS		LRCAD N12LRCAD P12VSS		VSS		122		LRCAD_N2 LRCAD_P2 VSS		1133	W	ENTES	TISTN	LOTARY	DE1TESTWODEOTRAP1E		TRAP14		
		VSS $\frac{1}{2}$	LTCAD_NT		Geräup 5 TSS		122	$\frac{1}{2}$	Ω Iss	\mathbb{R}	122			VSS FORM HUD 21 VSS		ISS.	ISS	135013		Q WD	TRAP1	TRAP12 STRAP11		TRAP10	TRAPS	TRAP8		
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		VSS	LTCAD_N11VSS	LTCAD_N8 VSS		LTCAD_N4 VSS		LTCAD N1 VSS		LRCAD_N14VSS		LRCAD_N11VSS		LACAD N8 TSS		LBCAD N4 VSS		LRCAD	N1 ISS	W	TRAP1	TRAPO	ADBIS	DB14	DB13	DB12		
		LTCAD_P13VSS		LTCAD_P9 VSS	LTCAD_P6 VSS		LTCAD_P3 VSS		ß	$\frac{1}{2}$	LRCAD_P13VSS		LRCAD_P9 VSS		LRCAD_P6 VSS		LRCAD_P3 VSS		$\frac{1}{2}$	VDD	[3]	0010	$^{\prime}$	DB8	DB7	DB\$		
		LTCAD_N13VSS		LTCAD N9 VSS	LTCAD N6 YSS		LTCAD N3 VSS			$\frac{1}{2}$	LRCAD N13VSS		LRCAD N9 VSS		LRCAD N6 VSS		LRCAD N3 VSS		1133	VDD	DB5	DB4		DB2	DB1	DBO.		
		$\frac{1}{2}$ VSS		LTCAD_N12VSS		LTCJA PI4LTCAD_N14VSS		$\frac{1}{2}$											W	VDOZ	W	WW		TOO	VDOZ	m		
		VSS	LTCAD_P151SS	VSS	$\frac{1}{2}$	$\sqrt{2}$		LTCLK_PO LTCLK_NO											W	133	VSS ₁	ZOIP N	M	VDD	ZOVP B	ZYREE		
		VSS	LTCAD_N15VSS		LTCLK_PL HTCLERO		$\frac{122}{122}$	VSS Ø											WHQ.	ZDREX	VSS ₁	VSS	$ZIX0$ c $ZSHE$			WD		
		VSS 122	$\frac{1}{2}$		LTOLK_NT VSS	YSS		LTCOMP_P LTCO						Corestize					0 \mathbb{R}	122	2STB#	ZSTB:			2STBO	ZAD16		
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					AUTOKO - PASETO	HSYNCO	VIII	п	ЫK	w	PART	w	MITIL	W	PATPI	122			run i	IW	FEAT I I	177	PAKP I D	122	WWW	Wik		
		IYYN			VOSCIO 75YNCO	VACLKO		$\frac{155}{25}$	VSS	PETN ^S	122	PETNS	VSS	PETN13	122	PERN	VSS		\mathbb{Z}	PERN9	VSS	PGW13	122	$\frac{122}{200}$	YDDPEX	VDDPEN		
		VBCLKO YRAN			VBSYNCO ^W VGP1010			133		PCTP ₅	122	PBTP:	VSS	PETP13	U22	PERF	Group		$\frac{1}{2}$	PERP ₃	VSS ₁	PERP13	122	$\frac{125}{25}$	VDOPEX	VDDPEN		
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										PETN-	$\frac{1}{3}$	PBTNG	VSS	PETN12	122		VSS	PERN	133	PERN8	VSS		$\frac{1}{2}$	REPOLKN	VDDPEX	VDDPB		
							W	vs		PETP ₄	$\frac{1}{2}$	PRTP8	VSS	PETP12	ISS		VSS	PERP	ISS	PERP8	VSS	PRRP12	ISS	REACTION		VITPA)		

Figure 2.13: Final floorplan in Case I. (uppercase P denotes the minimum package size, uppercase C denotes the minimum core size, uppercase N denotes nothing and pin-block groups are denoted in shaded blocks.)

Figure 2.14: Final floorplan in Case II. (uppercase P denotes the minimum package size, uppercase C denotes the minimum core size, uppercase N denotes nothing and pin-block groups are denoted in shaded blocks.)

Chapter 3

Improved Pin-Block Floorplanner

Chapter 2 shows the detail of implementing the automation process in [1]. The floorplanner in [1] exists some problems which have been described before. That is, the method in [1] is less flexible in determining pin configuration chart and the non-well positions generated from [1] will cause another cost as well. In this chapter, our target is trying to solve those problems and we improve the floopplanner in [1] by range constraint to place pin-blocks. Meanwhile, improved pin-block floorplanner is implemented by using the simulated annealing algorithm.

3.1 Problem Definition

The minimum package size has been evaluated from Chapter 2 and we use the minimum package size directly as a graphic frame of our problem. In our problem, the final packing is consisted of core block and several pin blocks around core block. The core block of the packing is just denoted as a module which is restricted by pre-placed constraint and the pin blocks around the core block are considered as modules that are restricted by range constraint [8]. Figure 3.1 briefly describes the placement of the core block and shows how the pin blocks without range constraint are placed around the core block.

In Figure 3.1, the whole floorplan is in the first quadrant with its lower left corner at the origin $(0, 0)$. The core block (C) which is restricted by pre-placed constraint can be

Figure 3.1: Final packing is consisted of core block and pin blocks without range constraint around the core block.

considered as a hard module with fixed orientation and the height of module C is denoted as h*core* and the width of it is denoted as w*core*. The core block must be placed with its lower left corner at (w_4, h_1) in the final packing. Because the pre-placed constraint is a special case of range constraint in which the module has no freedom of movement, so module C can be specified by a range constraint requiring the module to be placed within the rectangular region $R_{core} = \{(x, y) | w_4 \le x \le w_4 + w_{core}, h_1 \le y \le h_1 + h_{core}\}.$ Then, pin blocks without range constraint are placed around the core block. For side1, the height of pin blocks is defined as h_1 . Pin blocks are placed with fixed orientation and are assigned with its lower left corner at $(w_4, 0)$. Pin blocks are also placed toward the increasing direction of the x coordinate. Analogically, the height of pin blocks placed in side2 is defined as w_2 and pin blocks are assigned with its lower left corner at $(w_4 + w_{core} + w_2, h_1)$ toward the increasing direction of the y coordinate. And pin blocks placed in side3 with its height as h_3 are assigned with its lower left corner at $(w_4+w_{core}, h_1+h_{core}+h_3)$ toward

Figure 3.2: Pin blocks with the range constraint which must be placed within the given rectangular region.

the decreasing direction of the x coordinate. At last, pin blocks placed in side4 with its height as w_4 are assigned with its lower left corner at $(0, h_1 + h_{core})$ toward the decreasing direction of the y coordinate. This manner of placing pin blocks is equally like the rough floorplanning which is described before in Chapter 2. However, our problem defines the range constraint to floorplan pin blocks which is placed around the core block.

Figure 3.2 briefly shows an example about the definition of the range constraint for side1. We specify the rectangular region called $rangeSide1$ and pin blocks with range constraint must be placed within *rangeSide1*. Range constraints are listed below and shown in Figure 3.3:

- $rangeSide1 = \{(x, y) | 0 \le x \le w_4 + w_{core} + w_2, 0 \le y \le h_1 + h_{core}/2\}.$
- $rangeSide2 = \{(x, y)|w_4 + w_{core}/2 \le x \le w_4 + w_{core} + w_2, 0 \le y \le h_1 + h_{core} + h_3\}.$
- $rangeSide3 = \{(x, y) | 0 \le x \le w_4 + w_{core} + w_2, h_1 + h_{core}/2 \le y \le h_1 + h_{core} + h_3\}.$

• $rangeSide4 = \{(x, y) | 0 \le x \le w_4 + w_{core}/2, 0 \le y \le h_1 + h_{core} + h_3\}.$

A feasible packing must satisfy all placement constraints (including the pre-placed constraint and the range constraint). A feasible packing is a nonoverlap placement of all pin blocks in it, and all pin blocks can be accommodated within the feasible packing. Our target is to improve the floorplanner in [1] by using the range constraint and place pin blocks into better positions on package. And our objective function is formulated as $W+\rho P$, where W is the sum total wire length which is calculated the Manhattan distance between pins and the edge of each side which the pins belong to, P is a penalty term which is an estimation of the square distance between pins and their desired positions in each side, and ρ is a user-defined balance constant which controls the relative importance of wire length and penalty term in the objective function. Meanwhile, improved pin-block floorplanner is implemented by using simulated annealing algorithm.

3.2 Range Constrained Pin-Block Sequence Pair (RCPBSP)

We propose a novel sequence-pair representation to construct a scheme of our problem. This representation describes all varieties of perturbations in placing the pin blocks around the core block. For case I, the representation is resulted in $s = (123456, 1111111211112)$ IV1). The first sequence denotes groups (i.e. group1, group2,..., group6). The second sequence means the range constraint. They are I, II, III and IV, that is, $rangeSide1$, rangeSide2, rangeSide3 and rangeSide4, respectively. The number behind the rangeSide means the order of groups which are placed in the same range constraint. Figure 3.4 shows some examples of the representation in our problem.

In Figure 3.4, all floorplans are feasible packings which satisfy the range constraint in each side and the representation is showed under each graph. In Figure 3.4 (a), the placement of pin blocks is started from group1 with range Side1 and the sequence of groups is showed as (123456) in the anticlockwise direction. In Figure 3.4 (b), the placement is started from group3 with rangeSide2 and the sequence is (324561) . Group2 and group3

Figure 3.3: For the other sides, pin blocks with the range constraint must be placed within rangeSide2, rangeSide3 and rangeSide4.

Figure 3.4: Some examples of the representation in our problem.

have done pair-interchanged exchanging in this stage. Similarly, the representations of Figure 3.4 (c) and Figure 3.4 (d) are showed in the same way. And later we will describe the perturbations of this representation in detail.

3.3 Floorplanning with Range Constraint

In the aforementioned description, we know that all groups must be placed within a given rectangular region. Figure 3.5 illustrates an example where five groups with range constraint are restricted in $rangeSide1$. (group a, b, c, d and e, respectively). Because of hard modules, each group has the same height as eight. The width of each group is depended on the amount of signal pins and the pattern selected by user. So, the only thing that we care about is the total width of groups which must be placed within $rangeSide1$, where w_a, w_b, w_c, w_d and w_e denotes the width of group a, b, c, d and e, respectively. The total width of groups in $rangeSide1$ is $w_{s1} = w_a + w_b + w_c + w_d + w_e$. And the definition of $rangeSide1$ is shown as follows and illustrated in Figure 3.5 (b):

- R_s : The start point of *rangeSide1*, $R_s = 0$.
- R_e : The end point of *rangeSide1*, $R_e = R_s + h_{core}/2 + h_1 + w_{core} + w_2 + h_{core}/2$.
- Cs: The check start point of groups restricted by $rangeSide1$, $C_s = R_s + rd_a$.
- Ce: The check end point of groups restricted by $rangeSide1$, $C_e = C_s + w_{s1}$.

The minimum core size (C) of the chip is evaluated as $h_{core} * w_{core}$. And rd_a means random selected start-point of group a where group a should be placed from. Firstly, we consider the allowed range of all groups. For group a, the allowed range of module a can be denoted as $ar_a = R_e - w_a$, as shown in Figure 3.5 (c). The random selected start point (i.e. rd_a) should satisfy the restricted range $R_s \leq rd_a \leq ar_a$. Similarly, other groups are all obeying this rule of randomly selecting start point. A feasible solution of the floorplan will satisfy the range constraints as following rules:

Figure 3.5: An example illustrates groups with range constraint (range Side1).

- Random selected start-point should be within the restricted range: $R_s \leq rd_a \leq ar_a$.
- Total width of groups restricted by range Side1 should be within the spreading length of the given rectangular region: $C_s \geq R_s$ and $C_e \leq R_e$.

In addition, the start point of groups in $rangeSide2$ is carried on the checked end-point (C_s) of groups in rangeSide1. Groups in rangeSide2 are placed from the start point at $(C_s + 1)$ and the order of groups is following the representation mentioned before.

Analogously, the aforementioned rules are proper for other range constraints in each side. Consequently, we will acquire a feasible solution as long as the range constraints of the four sides are all satisfied and non-overlapping modules appear in the final packing.

3.4 RCPBSP Packing by Simulated Annealing

3.4.1 Solution Perturbation and Cost Function

Firstly, our problem is basically implemented on simulated annealing algorithm. We briefly describe perturbations in our representation.

- In the first step, we randomly select which $rangeSide$ should be perturbed.
- In the second step, we randomly select any two groups of *rangeSide* selected in first step and do pair-interchanged exchanging. If selected rangeSide has more than two groups, then the two groups selected in first step have done pair-interchanged exchanging. Otherwise, the sequence of our representation is still the same.
- In the final step, we randomly select the start point of the group with the first order in selected *rangeSide* and rearrange other groups by following the sequence of the representation until all *rangeSides* have been considered.

However, the cost function is defined as $W + \rho P$ where W is an estimation of total wire length which is Manhattan distance between signal pins and the edge of each side which

Figure 3.6: An estimation of wire length between signal pins belonged to range Side1 and the edge of side1.

signal pins belong to. P is a penalty term which is an estimation of the square distance between pins and their desired positions in each side, and ρ is a user-defined balance constant which controls the relative importance of wire length and penalty term in the objective function.

For range Side1, Figure 3.6 describes an estimation of wire length between signal pins belonged to $rangeSide1$ and the edge of side1. There are three parts of the estimation of the wire length. They are signal pins with $rangSide1$ placed in side4, signal pins with rangSide1 placed in side1 and signal pins with rangSide1 placed in side2. And the computation is translated as following form:

- Length = $|x-(-1)| + |y-(-1)|$, $0 \le x \le w_4, 0 \le y \le (h_1 + h_{core}/2)$
- Length $= |y|$. $w_4 \leqq x \leqq (w_4 + w_{core} + w_2), 0 \leqq y \leqq h_1$

Figure 3.7: An estimation of the penalty term which is the distance between pins and their desired positions in $rangeSide1$.

• Length =
$$
|x - (w_4 + w_{core} + w_2 + 1)| + |y - (-1)|
$$
,
\n $(x_4 + w_{core}) \le x \le (w_4 + w_{core} + w_2), h_1 \le y \le (h_1 + h_{core}/2)$

And other rangeSides are also following the manner of estimating the wire length.

Another estimation term of cost function is the penalty term and the evaluation of penalty term is also formulated as following form. But just for rangeSide1, as shown in Figure 3.7.

- $Penalty = [|y| + |(w_4 X_l)|]^2$, $0 \le x \le w_4, 0 \le y \le (h_1 + h_{core}/2)$
- $Penalty = [(x X_l)]^2, w_4 \leqq x \leqq X_l, 0 \leqq y \leqq h_1$
- $Penalty = 0, X_l \leq x \leq X_r, 0 \leq y \leq h_1$

•
$$
Penalty = [[(x - X_r)]]^2,
$$

\n $X_r \leq x \leq (w_4 + w_{core} + w_2), 0 \leq y \leq h_1$

• $Penalty = [|X_r - (w_4 + w_{core} + w_2)| + |(y - (h_1))|]^2$, $(w_4 + w_{core}) \leqq x \leqq (w_4 + w_{core} + w_2), h_1 \leqq y \leqq (h_1 + h_{core}/2)$

Where X_l denotes the left edge of the given desired position in the side1 and X_r represents the right edge of the given desired position in the side1. RangeSide2, rangeSide3 and rangeSide4 are also following this manner of estimating the penalty term.

Figure 3.8 reveals the desired positions in other three *range Sides* and the purpose of this specification is hopefully floorplanning the pins to the center of each side approximately. Besides the desired position assigned weight centrally, as shown in Figure 3.9 (a). There are two weight behaviors including left-position and right-position in order to make the final floorplan have rotating ability. Figure 3.9 (b) and Figure 3.9 (c) show the rotating ability of the final floorplan in clockwise direction and in anticlockwise direction, respectively.

3.4.2 Annealing Schedule

Our problem is implemented by using range constraint based on simulated annealing algorithm [16] and our annealing schedule is shown as follows: Simulated Annealing Schedule(S_0 , T_0 , α , β , M , M α $time$):

1. begin

2. $T = T_0;$

- 3. $S = S_0;$
- 4. $Time = 0;$

5. repeat

6. repeat

7. $NewS = range_constraint(S);$

- 8. $H = (Cost(NewS) Cost(S));$
- 9. If($(\triangle h < 0)$ or $(random < e^{-\triangle/T})$) then $S = NewS$;

Figure 3.8: Reveals the desired positions in other three rangeSides and the purpose of this specification is hopefully floorplanning the pins to the center of each side approximately.

Figure 3.9: Weight behavior : let the whole floorplan have rotate ability. (a) Center. (b) Clockwise. (c) Anticlockwise.

11. $M = M - 1;$

12. until $(M = 0)$

13. $Time = Time + M;$

- 14. $T = \alpha * T;$
- 15. $M = \beta * M;$
- 16. until $(Time \geq MaxTime);$
- 17. Output Best solution found;

18.End. (* of Simulated Annealing Schedule*)

Where S_0 is the initial solution, T_0 is the initial Temperature(defined as 100), α is the cooling rate(a typical value for α is 0.9), β is a constant(defined as 2), *Maxtime* is the total allowed time for the annealing process(defined as 500), M represents the time until the next parameter update(defined as 5), Δh is difference in costs, and T is the temperature. Range constraint function generates NewS of any given solution S and Cost function evaluates the cost values of NewS and S. In our annealing schedule, the initial solution is generated by several steps which are described as follows:

- In the first step, we randomly select a range Side and randomly select a group in that selected rangeSide.
- In the second step, we randomly select the start point of the selected group and place it, then we rearrange other groups which belong to the selected rangeSide in order.
- In final step, we rearrange other groups by following the original order which is specified by user until all *rangeSides* have been considered.

The annealing process is implemented iteratively to get a feasible solution with minimum cost and terminates when the total allowed time is less then the accumulative time.

Chapter 4

Experimental Results

We implemented our approach in the C++ Programming language and the platform is on $intel(R)$ Pentium (R) M CPU 1.7GHz work station with 512 MB memory. We used four industrial cases as our benchmarks (case I, case II, case III, case IV). Table 4.1 shows the summary of pin configuration charts about these four cases.

We carried out two sets of experiments. For the first set, we compared SA-random floorplanner and our improved pin-block floorplanner with the method in [1] by considering wire length as cost function. The experiment results and improvement are shown in Table 4.2, Figure 4.1 and Figure 4.2. Here we propose another method called SA-random floorplanner to implement these four cases. The main difference between SA-random method and our method is the order of placing groups. In SA-random method, although the generation of initial solution is the same with our method, but the perturbation is still using the manner of generating the initial solution and it place groups by following the original order which is specified by user. However, our method places groups by following RCPBSP and has more flexibility than SA-random method. In Figure 4.1 and Figure 4.2, Case I and Case II have the same amount of groups and the improvement of our method is equally like that of SA-random method. But, there are obvious improvements of our method in Case III and Case IV while the amount of groups increases gradually. In Figure 4.2, we can see that our improved pin-block floorplanner has improved over [1] in wire

	Group	Signal	Power	Total
	NO.	-pin	-pin	pin
			NO.	NO.
CaseI	6	254	80	334
CaseII	6	346	48	394
CaseIII	20	510	168	678
CaseIV	25	504	216	720

Table 4.1: The summary of these four industrial cases

length and there is a incremental trend of the improvement in wire length while the size of case increases gradually.

In the second set of experiments, we consider wire length and the penalty term simultaneously in cost function. And the penalty term has three different desired positions, including Left, Center and Right. The purposes of Left, Center and Right are hopefully floorplanning the pin-blocks to the left, center and right of each side approximately, respectively. The results and the improvement are shown in Table 4.3, Table 4.4, Table 4.5, Figure 4.3 and Figure 4.4. Our improved pin-block floorplanner has improved over [1] in three different desired positions. In order to comparing with [1], pin-blocks are hopefully placed in the center of each side approximately and Center becomes the most important desired position that we care. For Center, there is the improvement at least more than a 32 percent over [1] and Table 4.5 clearly shows that wire length and penalty term are both improved in CaseII, CaseIII and CseIV. In addition, we also use the results of the method in [1] to be our initial solutions. Then, we get the same results by implementing our improved pin-block floorplanner. Because, our method is implemented by using simulated annealing algorithm to place pin-blocks. Our method will be implemented iteratively until the global solution is found.

Figure 4.5 is our result packing of CaseII , whose cost function considers wire

Table 4.2: Experimental results of the method in [1] and our improved pin-block floorplanner by considering wire length as cost function

		$\lceil 1 \rceil$	SA-random floorplanner	Our improved pin-block floorplanner	Improvement(%)		
Data	n		Wire length		SA	Our	
CaseI	6	1199	1149	1149	$+4.17$	$+4.17$	
CaseII	6	1712	1640	1639	$+4.21$	$+4.26$	
CaseIII	20	2406	2226	2225	$+7.48$	$+7.52$	
CaseIV	25	2442	2240	2170	$+8.27$	$+11.14$	

Figure 4.1: Shows the improvement of wire length in four industrial cases ([1] vs. SArandom floorplanner).

Figure 4.2: Shows the improvement of wire length in four industrial cases ([1] vs. our improved pin-block floorplanner).

Figure 4.3: Illustrates the improvement of SA-random floorplanner by considering wire length and penalty term simultaneously in four industrial cases with $\rho=5$ ([1] vs. SArandom floorplanner).

							SA-random					
				$[1]$		floorplanner						
Data	$\mathbf n$				Sum=wLength+ ρ *penalty(ρ =5)							
			Left	Center	Right	Left	Center	Right				
		Penalty	12832	6200	3958	3156	2619	3156				
CaseI	6	$\le L$	1199	1199	1199	1361	1216	1158				
		Sum	65359	32199	20989	17141	14311	16938				
		Penalty	13668	8708	10838	6605	5802	7808				
CaseII	6	wL	1712	1712	1712	1994	1650	1750				
		Sum	70052	45252	55902	35019	30660	40790				
		Penalty	60665	27048	29744	19936	20853	21377				
CaseIII	20	$\le L$	2406	2406	2406	3294	2336	2765				
		Sum	305731	137646	151126	102974	106601	109650				
		Penalty	73239	31590	28750	21264	20348	25117				
CaseIV	25	wL	2442	2442	2442	2761	2263	2998				
		Sum	368637	160392	146192	109081	104003	128583				

Table 4.3: Shows experimental results of the method in [1] and SA-random floorplanner. Wire length and penalty term are considered simultaneously in cost function

				Our improved			
				pin-block			
				floorplanner			
Data	n			Sum=W+ ρ *P(ρ =5)			
			Left	Center	Right		
		Penalty	3156	2619	3156		
CaseI	6	wL	1361	1216	1158		
		Sum	17141	14311	16938		
		Penalty	6605	5802	7808		
CaseII	6	W _L	1994	1650	1750		
		Sum	35019	30660	40790		
		Penalty	13786	15579	18331		
CaseIII	20	W _L	2890	2236	2723		
		Sum	71820	80131	94378		
		Penalty	18018	16976	18645		
CaseIV	25	wL	2917	2201	2447		
		Sum	93007	95672 87081			

Table 4.4: Shows experimental results of our improved pin-block floorplanner. Wire length and penalty term are considered simultaneously in cost function

				Improvement $(\%)$										
				SA-random		Our improved								
				floorplanner		pin-block								
							floorplanner							
Data	$\mathbf n$		Left	Center	Right	Left	Center	Right						
		Penalty	$^{+}$	$^{+}$	$^{+}$	$^{+}$	$+ \nonumber$	$+$						
CaseI	6	wL			$^{+}$			$+$						
		Sum	$+73.77$	$+55.55$	$+19.3$	$+73.77$	$+55.55$	$+19.3$						
		Penalty	$^{+}$	$+$	$^{+}$	$^{+}$		$+$						
CaseII	6	$\le L$		$+$	$\qquad \qquad \blacksquare$		$\boldsymbol{+}$	$\overline{}$						
		Sum	$+50.01$	$+32.25$	$+27.03$	$+50.01$	$+32.25$	$+27.03$						
		Penalty	$^{+}$	$^{+}$	$^{+}$	$^{+}$	$+ \nonumber$	$^{+}$						
CaseIII	20	$\le L$		$^{+}$	$\overline{}$			÷,						
		Sum	$+66.32$	$+22.55$	$+27.44$	$+76.51$	$+41.78$	$+37.55$						
		Penalty	$^{+}$	$+$	$^{+}$	$^{+}$		$+$						
CaseIV	25	wL		$+$										
		Sum	$+70.41$	$+35.16$	$+12.05$	$+74.77$	$+45.71$	$+34.56$						

Table 4.5: Shows the improvement of SA-random floorplanner and our improved pin-block floorplanner by considering wire length and penalty term simultaneously

Figure 4.4: Illustrates the improvement of our improved pin-block floorplanner by considering wire length and penalty term simultaneously in four industrial cases with $\rho=5$ ([1] vs. our improved pin-block floorplanner).

length and penalty term in Center, where group 1 and 2 are constrained to be placed within rangeSide1 which is formed as a dotted line rectangle in Figure 4.5. Similarly, group 3 is within $rangeSide2$, group 4 is within $rangeSide3$, group 5 and 6 are within rangeSide4. By the way, the dotted line rectangles of other three rangeSide are not shown in Figure 4.5. Comparing with the final floorplan of CaseII which is shown in Figure 2.14, our packing avoids the empty positions appearing in non-well positions which will cause extra cost on wire length. And our packing also owns flexibility on the order of placing groups.

Figure 4.5: Our result packing of CaseII. The cost function considers wire length and penalty term in Center simultaneously.

Chapter 5

Conclusion and Future Work

We have proposed an improved pin-block floorplanner with range constraints in pin-out designation automation in flip-chip BGA package-board codesign. Our approach not only owns more flexible capability on placing groups, but also can avoid the non-well positions appearing in result packing. Furthermore, our approach can rotate the floorplan in final packing by exploiting the penalty term. It provides three different desired positions for user to select which floorplan is the most proper one in final packing. Experimental results reveal that our approach is better and more flexible than the method in [1].

About the future works, timing constraints is a critical issue of influencing the performance of our chip. The timing delay is accumulated outward form die to board and it could be considered in die-package-board codesign simultaneously. We should take the timing constraints into account to define our performance objectives. At the same time, we should extend our research inward in die-package codesign and try to place logic closer together so shorter routing resources can be used. In addition, the direction of placing pin blocks in four corners of result packing is pre-defined. Maybe, we can make the direction flexible and depend on which way can cause the lower cost.

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